### TOSHIBA Photocoupler

# TLP250(D4),TLP250F(D4),TLP251(D4),TLP251F(D4)

Attachment: Specifications for <u>VDE0884</u> option: (D4)

 $\begin{array}{c} \text{Types: TLP250,TLP251} \\ \text{TLP250F,TLP251F} \end{array}$ 

Type designations for 'option:  $(\underline{D4})$ ', which are tested under VDE0884 requirements.

Ex.: TLP250F (D4-LF4)

D4: VDE0884 option

LF4: Standard lead bend

Note: Use TOSHIBA standard type number for safety standard application.

Ex. TLP250F (D4–LF4) → TLP250F

### **VDE0884 Isolation Characteristics**

Description			Symbol	Rating	Unit
Application classification (DIN VDE0110 teil 2/ 01.89, table 1) for rated mains voltage≤300V <sub>RMS</sub> for rated mains voltage≤600 V <sub>RMS</sub>				I–III I–II	_
Climatic classification (DIN IEC68 teil 1 / 09.80)				40 / 100 / 21	_
Pollution degree (DIN VDE0110 teil 2 / 01.89)				2	_
Maximum operating insulation voltage	TLPxxx	type	V <sub>IORM</sub>	630	Vpk
	TLPxxxF	type		1140	
Input to output test voltage, method A Vpr = 1.5 × $V_{IORM}$ , type and sample test $t_p$ = 60s, partial discharge < 5pC	TLPxxx	type	Vpr	945	Vpk
	TLPxxxF	type		1710	
Input to output test voltage, method B Vpr = $1.875 \times V_{IORM}$ , 100% production test $t_p$ = 1s, partial discharge < 5pC	TLPxxx	type	Vpr	1180	Vpk
	TLPxxxF	type		2140	
Highest permissible overvoltage (transient overvoltage, t <sub>pr</sub> = 10s)	TLPxxx	type	V <sub>TR</sub>	4000	- Vpk
	TLPxxxF	type		6000	
Safety limiting values (max. permissible ratings in case of fault, also refer to thermal derating curve)  Current (input current I <sub>F</sub> , Psi = 0)  Power (output or total power dissipation)  Temperature			I <sub>si</sub> P <sub>si</sub> T <sub>si</sub>	100 800 150	mA mW °C
Insulation resistance, V <sub>IO</sub> = 500V, Ta = 25°C V <sub>IO</sub> = 500V, Ta = Tsi			R <sub>si</sub>	≥10 <sup>12</sup> ≥10 <sup>9</sup>	Ω

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## **Insulation Related Specifications**

		7.62mm pitch TLPxxx type	10.16mm pitch TLPxxxF type	
Minimum creepage distance(*)	Cr	6.4 mm	8.0mm	
Minimum clearance(*)	Cl	6.4 mm	8.0mm	
Minimum insulation thickness	ti	_		
Comperative tracking index (DIN IEC112 / VDE0303, part 1)	СТІ	175 (VDE0110 teil 2 / 01.89 group III a)		

(\*) in accordance with DIN VDE0110 teil 2 / 01.89, table 2, & 4

- 1. If a printed circuit is incorporated, the creepage distance and clearance may be reduced below this value(e.g.at a standard distance between soldering eye centres of 7.5mm). If this is not permissible, the user shall take suitable measures.
- 2. This photocoupler is suitable for 'safe electrical isolation' only within the safety limit data. Maintenance of the safety data shall be ensured by means of protective circuits.

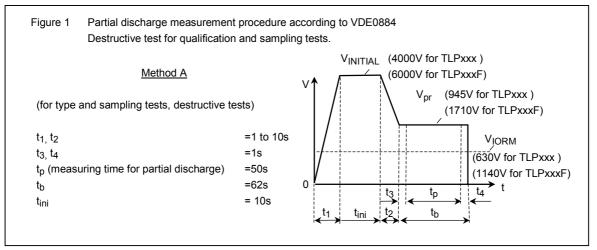
VDE Test sign: Marking on product for VDE0884

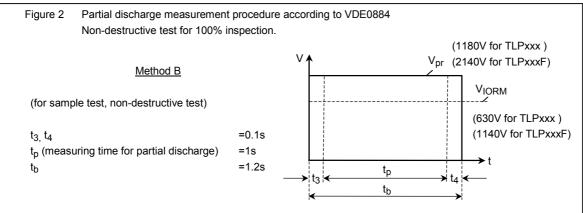


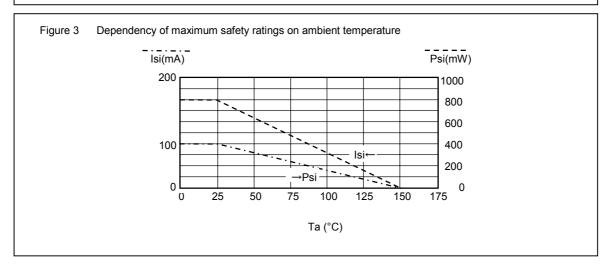
Marking on packing for VDE0884



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